

Search Notes

Application/Control No.

10/054,532

Examiner

Yvette C. Thornton

Applicant(s)/Patent under
Reexamination

LEE ET AL.


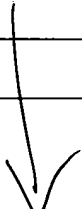

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	270.1	3/5/2005	YCT
430	286.1	↓	↓
430	905		
526	281		
526	256		
568	18		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
430	270.1	3/5/2005	
	286.1		
	905		
526/281, 256; 568/18			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search	3/5/2005	YCT